

Search Notes

Application/Control No.

10/081,968

Examiner

Jacob Y. Choi

Applicant(s)/Patent under
Reexamination

FUJINO ET AL.

Art Unit

2875

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|-----------------------------|------------|----------|
| 362 | 31, 331, 261, 339, 26 | 4/27/2005 | JC |
| 385 | 49, 88 | 4/27/2005 | JC |
| 385 | 146 | 4/27/2005 | JC |
| ALL | ALL | 11/4/2005 | JC |
| ALL | ALL | 11/13/2005 | JC |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |

INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|------|----------|
| | | | |
| | | | |
| | | | |
| | | | |

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|--|-----------|------|
| Class/Subclass Search 362 - John Ward | 4/26/2005 | JC |
| 385 - John Lee | 4/26/2005 | JC |
| Text Search performed by the examiner | 4/27/2005 | JC |
| | | |
| | | |
| | | |
| | | |
| | | |
| | | |
| | | |